

MOSFET - N-Channel, QFET®

600 V, 1.9 A, 4,7 Ω

FQD2N60C / FQU2N60C

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on–state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

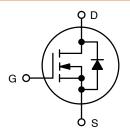
- 1.9 A, 600 V, $R_{DS(on)} = 4.7 \Omega$ (Max.) @ $V_{GS} = 10$ V, $I_D = 0.95$ A
- Low Gate Charge (Typ. 8.5 nC)
- Low Crss (Typ. 4.3 pF)
- 100% Avalanche Tested
- These Devices are Halid Free and are RoHS Compliant

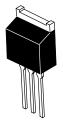
MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Symbol	Rating	Value	Unit
V _{DSS}	Drain-Source Voltage	600	V
I _D	Drain Current – Continuous ($T_C = 25^{\circ}C$) – Continuous ($T_C = 100^{\circ}C$)	1.9 1.14	Α
I _{DM}	Drain Current - Pulsed (Note 1)	7.6	Α
V _{GSS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	120	mJ
I _{AR}	Avalanche Current (Note 1)	1.9	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)	4.4	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *	2.5	W
	Power Dissipation (T _C = 25°C) - Derate above 25°C	44 0.35	W W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	–55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purposes, 1/8" (from case for 5 seconds)	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

V _{DSS}	R _{DS(ON)} MAX	I _D MAX
600 V	4.7 Ω @ 10 V	1.9 A



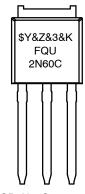




DPAK3 (IPAK) CASE 369AR

DPAK3 (TO-252 3 LD) CASE 369AS

MARKING DIAGRAMS





FQD2N60C,

FQU2N60C = Device Code \$Y = onsemi Logo &Z = Assembly Location &3 = Date Code

&K = Lot Run Traceability Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FQD2N60CTM	DPAK3 (TO-252 3 LD) (Pb-Free)	2500 / Tape & Reel
FQU2N60CTU	DPAK3 (IPAK) (Pb-Free)	70 Units / Tube

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case, Max.	2.87	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (minimum pad of 2 oz copper), Max.	110	°C/W
	Thermal Resistance, Junction-to-Ambient (* 1 in ² pad of 2 oz copper), Max.	50	

FI FCTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS		<u> </u>		<u></u>	
BV _{DSS}	Drain-to-Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	600	-	-	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	-	0.6	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600 V, V _{GS} = 0 V	-	-	1	μΑ
		V _{DS} = 480 V, T _C = 125°C	-	-	10	
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V	-	-	-100	nA
ON CHARAC	CTERISTICS		-			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain-Source On Resistance	V _{GS} = 10 V, I _D = 0.95 A	-	3.6	4.7	Ω
9FS	Forward Transconductance	V _{DS} = 40 V, I _D = 0.95 A	-	5.0	-	S
DYNAMIC C	HARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,	_	180	235	pF
C _{oss}	Output Capacitance	f = 1.0 MHz	-	20	25	1
C _{rss}	Reverse Transfer Capacitance	7	-	4.3	5.6	
SWITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 300 \text{ V}, I_D = 2 \text{ A},$	-	9	28	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$ (Note 4)	-	25	60	
t _{d(off)}	Turn-Off Delay Time	7	-	24	58	
t _f	Turn-Off Fall Time	7	-	28	66	
Q_g	Total Gate Charge	V _{DS} = 480 V, I _D = 2 A,	-	8.5	12	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V (Note 4)	-	1.3	-	
Q _{gd}	Gate-Drain Charge	7	-	4.1	-	
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND MA	XXIMUM RATINGS	-			
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	1.9	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Fo	Maximum Pulsed Drain-Source Diode Forward Current		-	7.6	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 1.6 A	-	-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 2 A,	-	230	-	ns
Q _{rr}	Reverse Recovery Charge	dl _F /dt = 100 A/μs	_	1.0	-	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product Product parametric performance is indicated in the Electrical Characteristics for the listed test condition performance may not be indicated by the Electrical Characteristics if operated under different conditions.
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. L = 56 mH, I_{AS} = 2 A, V_{DD} = 50 V, R_{G} = 25 Ω , Starting T_{J} = 25°C.
3. $I_{SD} \le 2.0$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T_{J} = 25°C.
4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

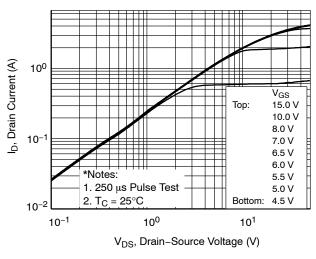


Figure 1. On-Region Characteristics

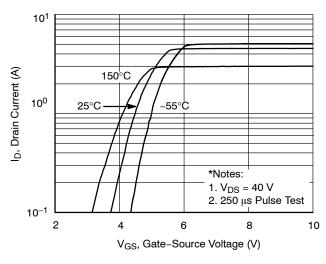


Figure 2. Transfer Characteristics

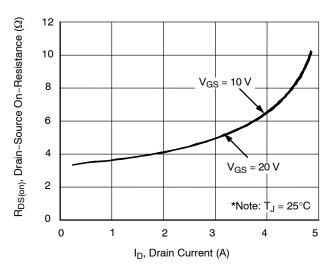


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

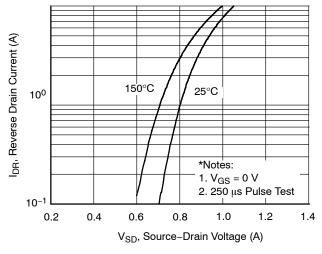


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

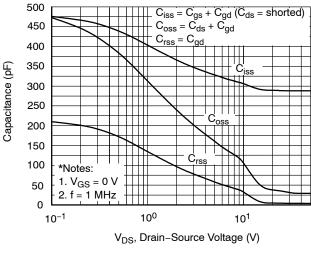


Figure 5. Capacitance Characteristics

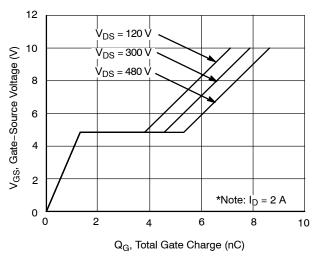
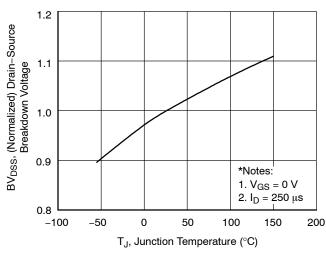


Figure 6. Gate Charge Characteristics

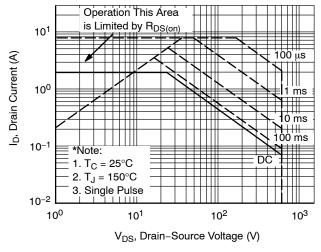
TYPICAL CHARACTERISTICS (continued)



3.0 R_{DS(ON)}, (Normalized) Drain-Source 2.5 2.0 On-Resistance 1.5 1.0 *Notes: 0.5 1. $V_{GS} = 10 V$ $2. I_D = 0.95 A$ 0.0 -50 -10050 100 150 200 T_J, Junction Temperature (°C)

Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On–Resistance Variation vs. Temperature



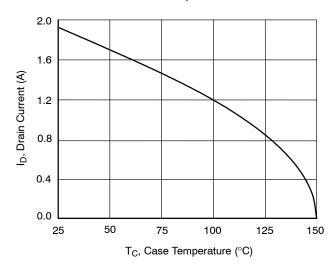


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

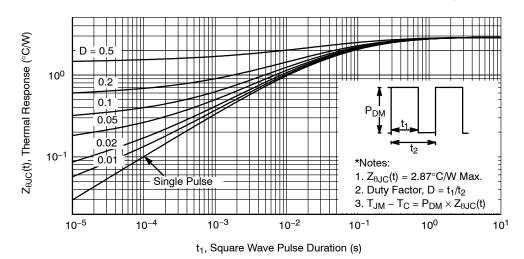


Figure 11. Transient Thermal Response Curve

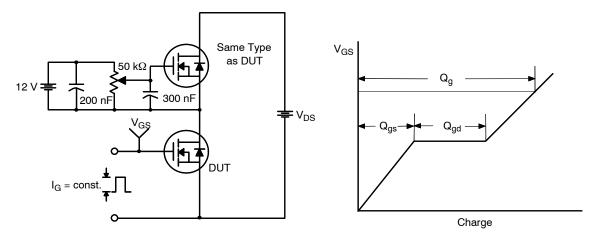


Figure 12. Gate Charge Test Circuit & Waveform

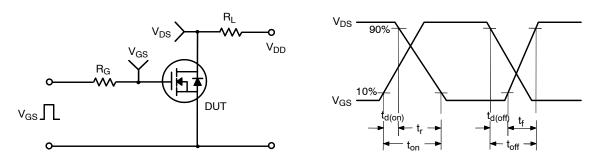


Figure 13. Resistive Switching Test Circuit & Waveforms

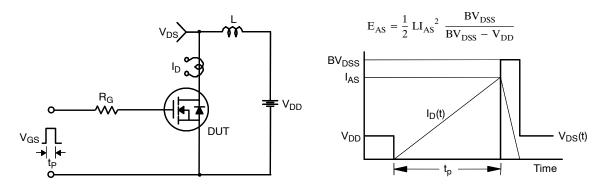
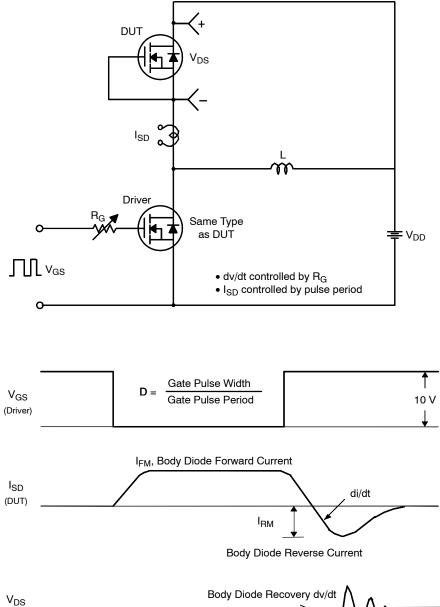


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Body Diode Recovery dv/dt

V_{SD}

Body Diode
Forward Voltage Drop

Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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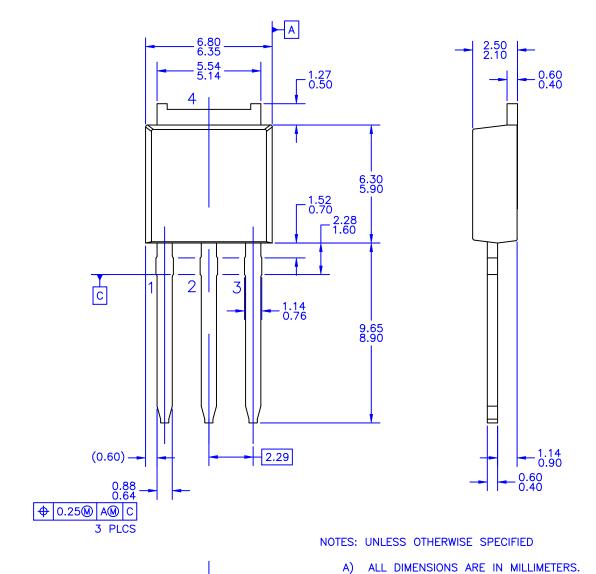
ISSUE C, VARIATION AA, DATED SEP 1988.

DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.



DPAK3 (IPAK) CASE 369AR ISSUE O

DATE 30 SEP 2016



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DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

DATE 20 DEC 2023

- NOTES: UNLESS DTHERWISE SPECIFIED

 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

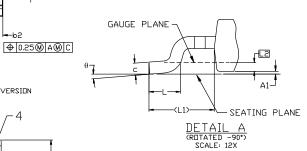
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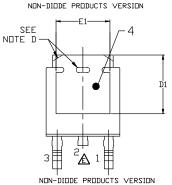
 - D)

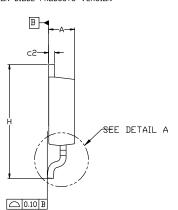
A

- F)
- DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-2018.
 SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 FOR DIODE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
 STUB WITHOUT CENTER LEAD.
 DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
 T0228P991X239-3N.



L4 θ			1.02 10°	
L3	0.89	1.08	1.27	
L2	0.51 BSC			
L1	2.90 REF			
L	1.40	1.59	1.78	
Н	9.40	9.91	10.41	
e1	4.5	572 BS	С	
е	2.2	286 BS	С	
E1	4.32			
E	6.35	6.54	6.73	
D1	5.21			
D	5.97	6.10	6.22	
c2	0.45	0.52	0.58	
С	0.45	0.53	0.61	
b3	5.21	5.34	5.46	
b2	0.76	0.95	1.14	
b	0.64	0.77	0.89	
A1	0.00	-	0.127	
Α	2.18	2.29	2.39	
ויונע	MIN.	N□M.	MAX.	
DIM	MILLIMETERS			





A

5.55	MIN
6,40	6.50 MIN
1 4.5	2.85 MIN 1.25 MIN 2.286

LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON DUR
PB-FREE STRATEGY AND SOLDERING DETAILS,
PLEASE DOWNLOAD THE ON SEMICONDUCTOR
SOLDERING AND MOUNTING TECHNIQUES
REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXXXX XXXXXX AYWWZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

Υ

WW = Work Week

77 = Assembly Lot Code

DESCRIPTION	DPΔK3 6 10x6 54x2 29 4 57P		PAGE 1 OF 1	
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